Technical Data

Size Diagonal 7" Active range (W × H) 152.4 × 91.44 mm² Resolution (W × H) 800 × 480 pixels Range 4 14,108 mm (555°) for longitudinal wave Display Display shift (delay) -15 3,500 µs Probe delay 0 1,000 µs Velocity 250 16,000 m/s PRF Automatically optimized 15 2,000 Hz, 3 automatic setting modes: Auto Low, Auto Med, Auto High, Manual Connectors Probe connectors 2 × LEMO-1 or 2 × BNC USB interface USB type B connector Service interface UEMO-1B, 8 pin Pulser Pulser woltage (SQ mode) 5pike pulser, optionally: Square-wave pulser Pulser width (SQ mode) 700 ms, in steps of 10 V with a tolerance of 10% Pulser amplitude (Spike mode) 10w: 120 V, high: 300 V (Spike mode) Damping 50 ohms, 1000 ohms Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Equivalent input noise 80 nV/Hz Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity 8 6B, SD-card Datasets UGO data structure in ASCII			
Active range (W × H) Resolution	Display screen		
Resolution (W × H) Range 414,108 mm (555") for longitudinal wave Display Display shift (delay) Probe delay Velocity Velocity Velocity PRF Automatically optimized 15 2,000 Hz, 3 automatic setting modes: Auto Low, Auto Med, Auto High, Manual Connectors Probe connectors Velocity Velocity Velocity Velocity PRF Automatically optimized 15 2,000 Hz, 3 automatic setting modes: Auto Low, Auto Med, Auto High, Manual Connectors Probe connectors Verification Ver		7"	
Range 4 14,108 mm (555s*) for longitudinal wave Display Display shift (delay) -15 3,500 µs Probe delay 0 1,000 µs Velocity 250 16,000 m/s PRF Automatically optimized 15 2,000 Hz, 3 automatic setting modes: Auto Low, Auto Med, Auto High, Manual Connectors Probe connectors 2 × LEMO-1 or 2 × BNC USB interface USB type B connector Service interface USB type B connector Service interface USB type B connector Service roltage (SQ mode) 120 300 V, in steps of 10 V with a tolerance of 10% Pulser voltage (SQ mode) 10 300 V, in steps of 10 N s Pulser width (SQ mode) 10 300 V, in steps of 10 N s Pulser amplitude (Spike mode) 10w: 120 V, high: 300 V Pulser amplitude (Spike mode) 10w: 30 ns, high: 100 ns Pulser energy (Spike mode) 10w: 30 ns, high: 100 ns Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Equivalent input noise Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Cates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Book and structure in ASCII	o , ,		
Display Display shift (delay) Probe delay Velocity Display shift (delay) Probe delay Velocity Display shift (delay) Display shift (delay) Display shift (delay) Display shift (delay) Display Spift (d	Resolution (W × H)	· · · · · · · · · · · · · · · · · · ·	
Display shift (delay) —15 3,500 µs Probe delay 0 1,000 µs Velocity 250 16,000 m/s PRF Automatically optimized 15 2,000 Hz, 3 automatic setting modes: Auto Low, Auto Med, Auto High, Manual Connectors Probe connectors 2 × LEMO-1 or 2 × BNC USB interface USB type B connector Service interface LEMO-1B, 8 pin Pulser Pulser woltage (SQ mode) \$20 300 V, in steps of 10 V with a tolerance of 10% Pulser width (SQ mode) \$30 500 ns, in steps of 10 ns mode) Pulser amplitude (Spike mode) \$10 w: 120 V, high: 300 V Spike mode) \$10 w: 120 V, high: 300 V Spike mode) \$10 w: 120 V, high: 100 ns Spike mode) \$10 w: 30 ns, high: 100 ns Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Equivalent input noise filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity 8 GB, SD-card Datasets UGO data structure in ASCII	Range	4 14,108 mm (555") for longitudinal wave	
Probe delay Velocity 250 16,000 m/s PRF Automatically optimized 15 2,000 Hz, 3 automatic setting modes: Auto Low, Auto Med, Auto High, Manual Connectors Probe connectors 2 × LEMO-1 or 2 × BNC USB interface USB type B connector Service interface LEMO-1B, 8 pin Pulser Pulser woltage (SQ mode) 20 300 V, in steps of 10 V with a tolerance of 10% Pulser walth (SQ mode) Pulser woltage (SQ mode) 10w: 120 V, high: 300 V Spike mode) Pulser energy (Spike mode) Damping 50 ohms, 1000 ohms Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Equivalent input noise Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Memory Card slot SD-card slot for all standard SD-cards Regaive Indivative in ASCII	Display		
Velocity PRF Automatically optimized 15 2,000 Hz, 3 automatic setting modes: Auto Low, Auto Med, Auto High, Manual Connectors Probe connectors 2 × LEMO-1 or 2 × BNC USB interface USB type B connector Service interface LEMO-1B, 8 pin Pulser Pulser mode Spike pulser, optionally: Square-wave pulser Pulser voltage (SQ mode) 120 300 V, in steps of 10 V with a tolerance of 10% Pulser width (SQ max. 10 ns Pulser width (SQ mode) Iow: 120 V, high: 300 V Spike mode) Pulser amplitude (Spike mode) Iow: 120 V, high: 100 ns Pulser energy (Spike mode) Damping 50 ohms, 1000 ohms Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Equivalent input noise Filters Broadband: 1-5 MHz / 2, 2,25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity Bates	Display shift (delay)	−15 3,500 µs	
PRF Automatically optimized 15 2,000 Hz, 3 automatic setting modes: Auto Low, Auto Med, Auto High, Manual Connectors Probe connectors 2 × LEMO-1 or 2 × BNC USB interface USB type B connector Service interface LEMO-1B, 8 pin Pulser Pulser mode Spike pulser, optionally: Square-wave pulser voltage (SQ mode) 120 300 V, in steps of 10 V with a tolerance of 10% Pulser falling/rising time Pulser width (SQ max. 10 ns time) Pulser amplitude (Spike mode) low: 120 V, high: 300 V Spike mode) Pulser energy (Spike mode) Damping 50 ohms, 1000 ohms Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Equivalent input noise Filters Broadband: 1-5 MHz / 2, 2:25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Cates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity Battonian USB type B connector Spike Mode Spike Mo			
Connectors Probe connectors Probe connectors 2 × LEMO-1 or 2 × BNC USB interface USB type B connector Service interface LEMO-1B, 8 pin Pulser Pulser voltage (SQ mode) Spike pulser, optionally: Square-wave pulser Pulser voltage (SQ mode) Tolerance of 10% Pulser width (SQ max. 10 ns pulser amplitude (Spike mode) Pulser amplitude (Spike mode) Pulser amplitude (Spike mode) Damping So ohms, 1000 ohms Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth Sq nod) Analog bandwidth Sq nod) Positive half-wave, negative half-wave, full wave, RF signal Cates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity B Gatesses	Velocity	250 16,000 m/s	
Probe connectors USB interface USB type B connector Service interface LEMO-1B, 8 pin Pulser Pulser mode Spike pulser, optionally: Square-wave pulser Pulser voltage (SQ mode) Pulser falling/rising time Pulser width (SQ mode) Pulser amplitude (Spike mode) Pulser energy (Sqbike mode) Pulser energy (Sqbike mode) Damping Positive for 30 m/√Hz Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Spike mode) SD-card slot for all standard SD-cards Service interface USB type B connector LEMO-1B, 8 pin Spike pulser, optionally: Square-wave pulser ave pulser, optionally: Square-wave pulser pulser voltage (SQ mode) 10 max. 10 ns	PRF	3 automatic setting modes: Auto Low,	
USB interface Service interface LEMO-1B, 8 pin Pulser Pulser mode Spike pulser, optionally: Square-wave pulser Pulser voltage (SQ mode) 120 300 V, in steps of 10 V with a tolerance of 10% Pulser falling/rising imax. 10 ns Pulser width (SQ mode) low: 120 V, high: 300 V Spike mode) Pulser amplitude (Spike mode) Pulser energy (Spike mode) Damping 50 ohms, 1000 ohms Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Equivalent input noise Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity Datasets UGO data structure in ASCII	Connectors		
Pulser mode Spike pulser, optionally: Square-wave pulser voltage (SQ mode) Pulser falling/rising time Pulser width (SQ mode) Pulser width (SQ mode) Pulser amplitude (Spike mode) Pulser energy (Spike mode) Damping Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth Equivalent input noise Filters Positive half-wave, negative half-wave, full wave, RF signal Gates Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot Capacity By Spike pulser, optionally: Square-wave pulser, optionally: Square-wave pulser, optionally: Square-wave pulser of 10 V with a tolerance of 10% o	Probe connectors	2 × LEMO-1 or 2 × BNC	
Pulser mode Spike pulser, optionally: Square-wave pulser Pulser voltage (SQ mode) Pulser falling/rising time Pulser width (SQ max. 10 ns Pulser width (SQ mode) Pulser amplitude (Spike mode) Pulser energy (Spike mode) Pulser energy (Spike mode) Damping Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth O.5 20 MHz Equivalent input noise Filters Positive half-wave, negative half-wave, full wave, RF signal Gates Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot Capacity By Spike pulser, optionally: Square-wave pulser wave pulser wave pulser. Spike pulser, optionally: Square-wave pulser in steps of 10 v with a tolerance of 10 with a tolerance of 10 with a tolerance of 10 ms. Spike pulser, optionally: Square-wave pulser in steps of 10 v with a tolerance of 10 with a tolerance of 10 ms. Spike pulser, optionally: Square-wave pulser in steps of 10 v with a tolerance of 10 with a tolerance of 10 ms. Spike pulser, optionally: Square-wave pulser in steps of 10 v with a tolerance of 10 with a tolerance of 10 ms. Spike pulser, optionally: Square-wave pulser in steps of 10 v with a tolerance of 10 ms. Spike pulser, optionally: Square-wave pulser in steps of 10 ns. Spike pulser, optionally: Square-wave pulser in steps of 10 ns. Spike pulser. Spike pulser, optionally: Square-wave pulser in steps of 10 ns. Spike pulser. Spike pulser. Spike pulser, optionally: Square-wave pulser in steps of 10 ns. Spike pulser. Spik	USB interface	USB type B connector	
Pulser mode Spike pulser, optionally: Square-wave pulser Pulser voltage (SQ mode) 120 300 V, in steps of 10 V with a tolerance of 10% Pulser falling/rising time max. 10 ns Pulser width (SQ	Service interface	LEMO-1B, 8 pin	
Pulser mode Spike pulser, optionally: Square-wave pulser Pulser voltage (SQ mode) 120 300 V, in steps of 10 V with a tolerance of 10% Pulser falling/rising time max. 10 ns Pulser width (SQ	Pulsar		
Pulser voltage (SQ mode) Pulser falling/rising time Pulser width (SQ mode) Pulser width (SQ mode) Pulser amplitude (Spike mode) Pulser energy (Spike mode) Damping Postage width (SQ mode) Pulser energy (Spike mode) Damping Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity Datasets UGO data structure in ASCII			
time Pulser width (SQ mode) Pulser amplitude (Spike mode) Pulser energy (Spike mode) Damping Feceiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth Equivalent input noise Filters Broadband: 1–5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity Datasets UGO data structure in ASCII		120 300 V, in steps of 10 V with a tolerance	
mode) Pulser amplitude (Spike mode) Pulser energy (Spike mode) Damping Domping		max. 10 ns	
(Spike mode) Pulser energy (Spike mode) Damping 50 ohms, 1000 ohms Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Equivalent input noise Filters Broadband: 1−5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot Capacity SD-card slot for all standard SD-cards Capacity Datasets UGO data structure in ASCII		30 500 ns, in steps of 10 ns	
(Spike mode) Damping 50 ohms, 1000 ohms Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Equivalent input noise 80 nV/√Hz Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity 8 GB, SD-card Datasets UGO data structure in ASCII		low: 120 V, high: 300 V	
Receiver Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth Equivalent input noise Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity B GB, SD-card Datasets UGO data structure in ASCII	Pulser energy (Spike mode)	low: 30 nS, high: 100 nS	
Digital gain Dynamic range 110 dB, adjustable in steps of 0.2 dB Analog bandwidth 0.5 20 MHz 480 nV/√Hz Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity B GB, SD-card Datasets UGO data structure in ASCII	Damping	50 ohms, 1000 ohms	
in steps of 0.2 dB Analog bandwidth 0.5 20 MHz Equivalent input noise	Receiver		
Equivalent input noise Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity B GB, SD-card Datasets UGO data structure in ASCII	Digital gain		
Filters Broadband: 1-5 MHz / 2, 2.25 MHz / 4, 5 MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity B GB, SD-card Datasets UGO data structure in ASCII	Analog bandwidth	0.5 20 MHz	
MHz / 10 MHz / 13, 15 MHz Rectification Positive half-wave, negative half-wave, full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity B GB, SD-card Datasets UGO data structure in ASCII		<80 nV/√Hz	
full wave, RF signal Gates Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity B GB, SD-card Datasets UGO data structure in ASCII	Filters		
Independent gates Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity B GB, SD-card Datasets UGO data structure in ASCII	Rectification		
Gate C (option, triggering by gate A or B) Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity 8 GB, SD-card Datasets UGO data structure in ASCII	Gates		
Measurement mode Peak, Flank, J-FLANK, FIRST PEAK Memory Card slot SD-card slot for all standard SD-cards Capacity 8 GB, SD-card Datasets UGO data structure in ASCII	Independent gates	Gates A and B (triggering by gate A), Gate C (option, triggering by gate A or B)	
Card slot SD-card slot for all standard SD-cards Capacity 8 GB, SD-card Datasets UGO data structure in ASCII	Measurement mode		
Capacity 8 GB, SD-card Datasets UGO data structure in ASCII	Memory		
Datasets UGO data structure in ASCII	Card slot	SD-card slot for all standard SD-cards	
	Capacity	8 GB, SD-card	
Reports JPG or BMP format	Datasets	UGO data structure in ASCII	
	Reports	JPG or BMP format	

General		
Battery	Li-lon, operating time: 13 hours with full charge / Charging method (standard): internal with power adapter / Charging method (optional): external charger / Charge level: proportional charge level indicator	
Power adapter	Universal power supply unit 100 240 VAC, 50/60 Hz	
Size (W × H × D)	255 × 177 × 100 mm (10" × 7.0" × 3.9")	
Weight	2.2 kg incl. battery	
Languages	Bulgarian, Chinese, Czech, Dutch, English, Finnish, French, German, Hungarian, Italian, Japanese, Norwegian, Polish, Portuguese, Romanian, Russian, Spanish, Swedish	
Damp heat and humidity (storage)	EN 60068 Part 2-30 6 cycles: 9 hrs at +25°C up in 3 hrs to +55°C, 9 hrs at +55°C then down to +25°C in 3 hrs, at 93% humidity	
Vibration	EN 60068 Part 2-6 2g per axis, 5 150 Hz, 1 oct/min, 25 cycles	
Shocks	EN 60068 Part 2-27 1000 cycles per axis, 15 g, 11 ms, half-sine	
Enclosure	IP66 according to IEC 60529	
Operating temperature	−10 55°C	
Cold operation	−10°C for 16 hrs, 502.5 Procedure II	
Heat operation	+55°C for 16 hrs, 501.5 Procedure II	
Storage temperature	-20 +60°C, without battery	
Cold storage	-20°C for 72 hrs, 502.5 Procedure I	
Heat storage	+70°C for 48 hrs, 501.5 Procedure I	
Options		
AWS	AWS calibration tool, according to AWS D1.1 Structural Welding Code	
DAC/JISDAC/CNDAC	DAC calibration tool, 16 points, according to EN 1712, EN 1713, EN 1714, ASTM E164, ASME, ASME III, JIS Z3060, GB11345 TCG: 120 dB dynamic, 110 dB/µs slope	
DGS	DGS calibration tool, according to: EN 1712, EN 1713, EN 1714, ASTM E164	
Data logger	Grid file creation	
3G	Gate C	
SWP	For pulser parameter optimization, voltage setting 120 300 V in steps of 10 V, pulse width setting 30 500 ns in steps of 10 ns	
Phantom-PRF	Phantom-PRF for the identification of erroneous echoes caused by multiple reflections in low-attenuation materials	
BEA	Blackwall Echo Attenuation	
Specifications accor	eding to EN 12668	

Specifications according to EN 12668

You will find the specifications according to EN 12668 for your instrument on the product CD included in the standard package.



Copyright 2020 Baker Hughes Company. This material contains one or more registered trademarks of Baker Hughes Company and its subsidiaries in one or more countries. All third-party product and company names are trademarks of their respective holders.

BHFF20067_EN (10/2020) waygate-tech.com